	•	`	
	59.	Probe Card Assembly, according to claim 58, wherein the means for adjusting the	
	planarity of th	e space transformer comprises:	
		an actuator, responsive to a computer, acting upon the space transformer	
,			
•	60.	Probe Card Assembly, according to claim 53, wherein:	
)		the contact pads are disposed at a first pitch on the second surface of the space	
	transformer;		
		the first plurality of contact structures each having a contact region, the contact	
/	region dispose	d at a second pitch; and	
		the first pitch is greater than the second pitch wherein the first pitch is a shortest	
	distance between	en any two adjacent contact pads and the second pitch is a shortest distance between	

REMARKS

Entry of the foregoing amendments prior to examination is respectfully requested.

Respectfully submitted,

BLAKELY, SOKOLOFF, TAYLOR & ZAFMAN LLP

Date: 6/1/99

any two adjacent contact structures .-

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I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 2023 on June 9 1999.

D.C. 20231 on Jurie 9/ 1999.

Date